TOSHIBA

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSII)

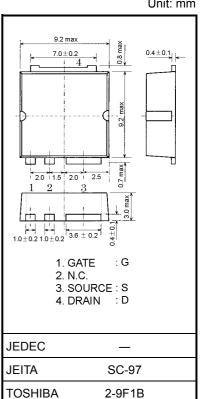
2SK3397

Relay Drive and DC-DC Converter Applications Motor Drive Applications

- Low drain-source ON resistance: R_{DS} (ON) = 4.0 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 110 \text{ S}$ (typ.)
- Low leakage current: $I_{DSS} = 10 \ \mu A (max) (V_{DS} = 30 \ V)$
- Enhancement-model: V_{th} = 1.5 to 3.0 V (V_{DS} = 10 V, I_D = 1 mA) •

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	30	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	30	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	۱ _D	70	А	
	Pulse (Note 1)	I _{DP}	210	A	
Drain power dissipation (Tc = 25° C)		PD	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	273	mJ	
Avalanche current		I _{AR}	70	А	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55 to150	°C	



Weight: 0.74 g (typ.)

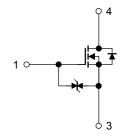
Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.0	°C/W

- Note 1: Please use devices on condition that the channel temperature is below 150°C.
- Note 2: $V_{DD} = 25 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (initial), L = 40 μ H, I_{AR} = 70 A, $R_G = 25 \Omega$
- Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

Circuit Configuration



Unit: mm

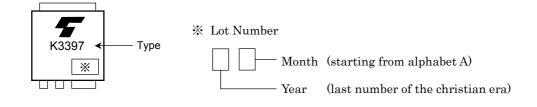
Electrical Characteristics (Ta = 25°C)

Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cur	rent	I _{GSS}	$V_{GS}=\pm 16~V,~V_{DS}=0~V$	_		±10	μA	
Drain cut-OFF cu	irrent	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_	—	10	μA	
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	_		V	
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15	_	_	v	
Gate threshold ve	oltage	V _{th}	$V_{DS} = 10 \ V, \ I_D = 1 \ mA$	1.5	—	30	V	
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \ V, \ I_D = 35 \ A$	_	4.0	6.0	mΩ	
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 35 \text{ A}$	55	110	—	S	
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	5000	_	pF	
Reverse transfer capacitance		C _{rss}		_	550	_		
Output capacitance		C _{oss}		_	1000	_		
Switching time	Rise time	tr	$V_{GS}^{10 V} \downarrow_{D} = 35 \text{ A} \\ 0 V \downarrow_{GS}^{C} \downarrow_{D} \neq 0 \\ V_{DD} \approx 15 \text{ V}$ $V_{DD} \approx 15 \text{ V}$	_	8.0	_	• ns	
	Turn-ON time	t _{on}		_	25	_		
	Fall time	t _f			48	_		
	Turn-OFF time	t _{off}			180	_		
Total gate charge (gate-source plus gate-drain)		Qg			110		nC	
Gate-source charge		Q _{gs}	$V_{DD} \simeq 24$ V, $V_{GS} = 10$ V, $I_D = 70$ A	_	87	—		
Gate-drain ("miller") charge		Q _{gd}		_	23	—		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	70	А
Pulse drain reverse current (Note 1)	I _{DRP}	—	_	_	210	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 70 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 70 A, V _{GS} = 0 V,	_	40	_	ns
Reverse recovery charge	Q _{rr}	dI _{DR} /dt = 30 A/µs	_	40	_	nC

Marking



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